Notice of References Cited

Application/Control No. 10/784,239	Reexamination	Applicant(s)/Patent Under Reexamination YANG, JUN-LONG	
Examiner	Art Unit		
Hanh V. Tran	3637	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,302,016 A	04-1994	Lautenschlager et al.	312/333
	В	US-6,652,050 B2	11-2003	Lin, Chun Wei	312/333
	С	US-2004/0000850 A1	01-2004	Lam Harn et al.	312/333
	D	US-6,733,097 B2	05-2004	Kim et al.	312/333
	Е	US-2004/0183411 A1	09-2004	Boks, Michael J.	312/333
	F	US-6,799,817 B1	10-2004	Chu, Leo	312/333
	G	US-2004/0227438 A1	11-2004	Tseng et al.	312/333
	н	US-2004/0239218 A1	12-2004	Jurja, Samuel	312/333
	_	US-6,848,759 B2	02-2005	Doornbos et al.	312/319.1
	J	US-2005/0093406 A1	05-2005	Yang, Jun-Long	312/333
	к	US-2005/0104492 A1	05-2005	Chiu, Susan	312/333
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	391221	10-1990	Europe	Roeck	312/333
	0					
	Р					
	Q				· ·	
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	٦	
	>	
	8	
:	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.